

## Single P-Channel MOSFET

### DESCRIPTION

SMC4863NA is the P-Channel enhancement mode power field effect transistors are using trench DMOS technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior, fast switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency load switching applications.

### PART NUMBER INFORMATION

**SMC 4863 NA - TR G**  
a b c d e

- a : Company name.
- b : Product Serial number.
- c : Package code           NA:DFN3.3X3.3A-8
- d : Handling code         TR:Tape&Reel
- e : Green produce code   G:RoHS Compliant

### FEATURES

**$V_{DS}=-30V$ ,  $I_D=-41A$**

$R_{DS(ON)}=9.5m\Omega(Typ.)@V_{GS}=-10V$

$R_{DS(ON)}=13m\Omega(Typ.)@V_{GS}=-4.5V$

- ◆100% UIS and Rg tested
- ◆High power and current handling capability

### APPLICATIONS

- ◆Power Management
- ◆Load switch



### ABSOLUTE MAXIMUM RATINGS ( $T_A=25^{\circ}C$ Unless otherwise noted)

Symbol	Parameter	Rating	Units
$V_{DSS}$	Drain-Source Voltage	-30	V
$V_{GSS}$	Gate-Source Voltage	$\pm 25$	V
$I_D$	Continuous Drain Current	$T_C=25^{\circ}C$	-41
		$T_C=100^{\circ}C$	-26
$I_{DM}$	Pulsed Drain Current <sup>B</sup>	-164	A
$I_D$	Continuous Drain Current	$T_A=25^{\circ}C$	-12.8
		$T_A=70^{\circ}C$	-10.3
$P_D$	Power Dissipation <sup>A</sup>	$T_A=25^{\circ}C$	3.1
		$T_A=70^{\circ}C$	2
$I_{AS}$	Single Pulse Avalanche Current <sup>B</sup>	-30	A
$E_{AS}$	Single Pulse Avalanche energy $L=0.1mH$ <sup>B</sup>	45	mJ
$P_D$	Power Dissipation <sup>C</sup>	$T_C=25^{\circ}C$	31.3
		$T_C=100^{\circ}C$	12.5
$T_J$	Operation Junction Temperature	-55/150	$^{\circ}C$
$T_{STG}$	Storage Temperature Range	-55/150	$^{\circ}C$

### THERMAL RESISTANCE

Symbol	Parameter	Typ	Max	Units
$R_{\theta JA}$	Thermal Resistance Junction to Ambient <sup>A</sup>	$t \leq 10s$	40	$^{\circ}C/W$
	Thermal Resistance Junction to Ambient <sup>AC</sup>	Steady-State	60	
$R_{\theta JC}$	Thermal Resistance Junction to Case		4	

## ELECTRICAL CHARACTERISTICS ( $T_A=25^\circ\text{C}$ Unless otherwise noted)

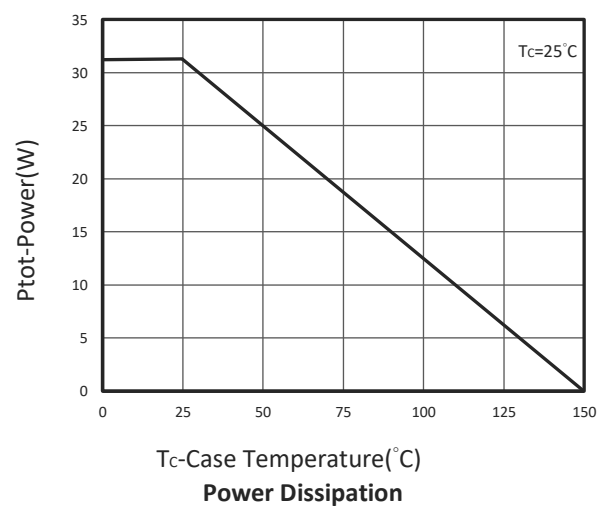
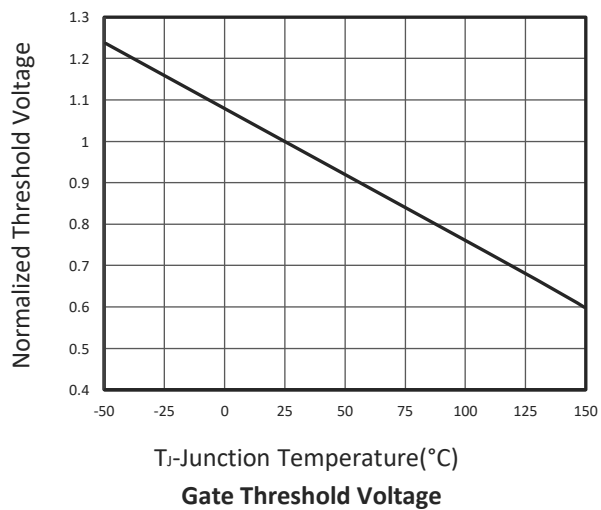
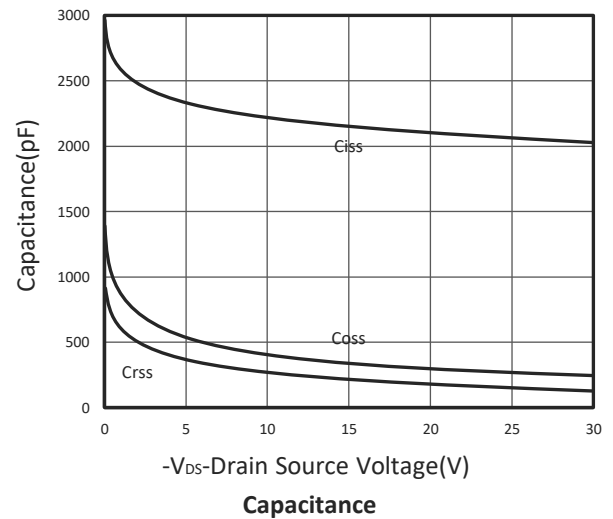
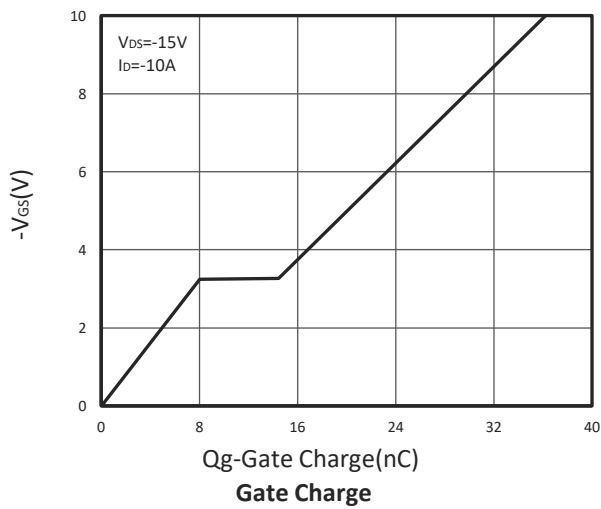
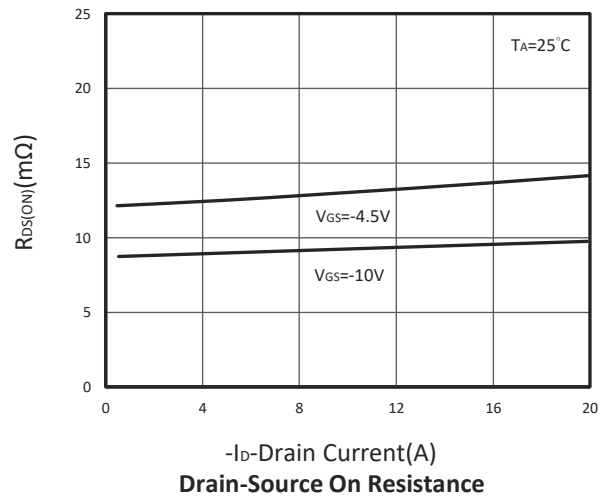
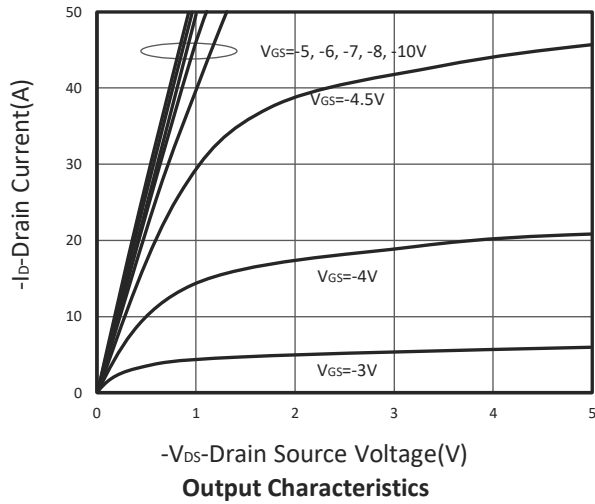
Symbol	Parameter	Condition	Min	Typ	Max	Unit
<b>Static Parameters</b>						
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> =0V, I <sub>D</sub> =-250 $\mu$ A	-30			V
V <sub>GS(th)</sub>	Gate Threshold Voltage	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =-250 $\mu$ A	-1	-1.6	-2.5	V
I <sub>GSS</sub>	Gate Leakage Current	V <sub>DS</sub> =0V, V <sub>GS</sub> = $\pm$ 25V			$\pm$ 100	nA
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> =-30V, V <sub>GS</sub> =0V, T <sub>J</sub> =25 $^\circ$ C			-1	$\mu$ A
		V <sub>DS</sub> =-24V, V <sub>GS</sub> =0V, T <sub>J</sub> =75 $^\circ$ C			-10	
R <sub>DS(ON)</sub>	Drain-source On-Resistance <sup>D</sup>	V <sub>GS</sub> =-10V, I <sub>D</sub> =-12.8A V <sub>GS</sub> =-4.5V, I <sub>D</sub> =-10A		9.5 13	12 17	m $\Omega$
G <sub>fs</sub>	Forward Transconductance	V <sub>DS</sub> =-10V, I <sub>D</sub> =-10A		12.5		S
<b>Diode Characteristics</b>						
V <sub>SD</sub>	Diode Forward Voltage <sup>D</sup>	I <sub>S</sub> =-1A, V <sub>GS</sub> =0V		-0.7	-1	V
I <sub>S</sub>	Diode Continuous Forward Current				-41	A
t <sub>rr</sub>	Reverse Recovery Time	I <sub>S</sub> =-10A, dI/dt=100A/ $\mu$ s		13.8		ns
Q <sub>rr</sub>	Reverse Recovery Charge			12.3		nC
<b>Dynamic and Switching Parameters<sup>E</sup></b>						
Q <sub>g</sub>	Total Gate Charge	V <sub>DS</sub> =-15V, V <sub>GS</sub> =-10V I <sub>D</sub> =-10A		36	48.6	nC
Q <sub>g</sub>	Total Gate Charge (4.5V)			18	24.3	
Q <sub>gs</sub>	Gate-Source Charge			8.1	10.9	
Q <sub>gd</sub>	Gate-Drain Charge			6.8	9.2	
C <sub>iss</sub>	Input Capacitance	V <sub>DS</sub> =-15V, V <sub>GS</sub> =0V, f =1MHz		2150		pF
C <sub>oss</sub>	Output Capacitance			298		
C <sub>rss</sub>	Reverse Transfer Capacitance			135		
R <sub>g</sub>	Gate Resistance	V <sub>GS</sub> =0V, V <sub>DS</sub> =0V, F=1MHz		8.8		$\Omega$
t <sub>d(on)</sub>	Turn-On Time	V <sub>DD</sub> =-15V, V <sub>GEN</sub> =-10V R <sub>G</sub> =3.3 $\Omega$ , I <sub>D</sub> =-1A		7.7	15	nS
t <sub>r</sub>				57.8	129	
t <sub>d(off)</sub>	Turn-Off Time			57.5	109	
t <sub>f</sub>				21.3	40	

Note: Absolute maximum ratings are those values beyond which the device could be permanently damaged.

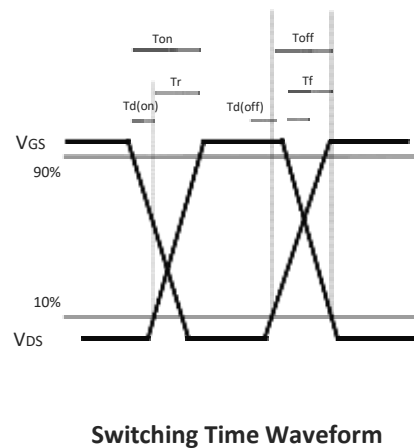
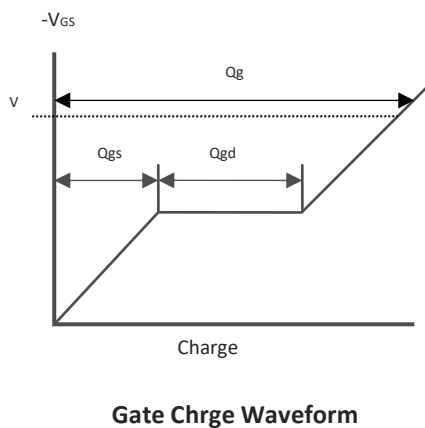
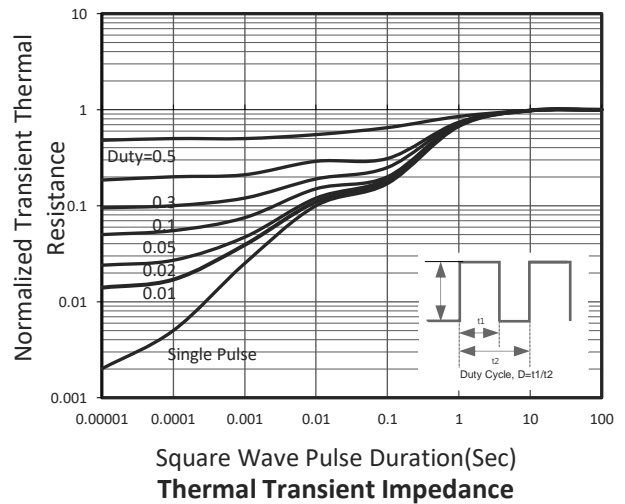
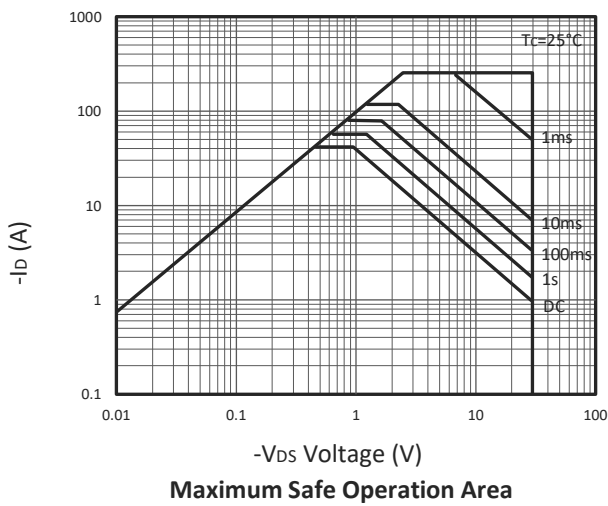
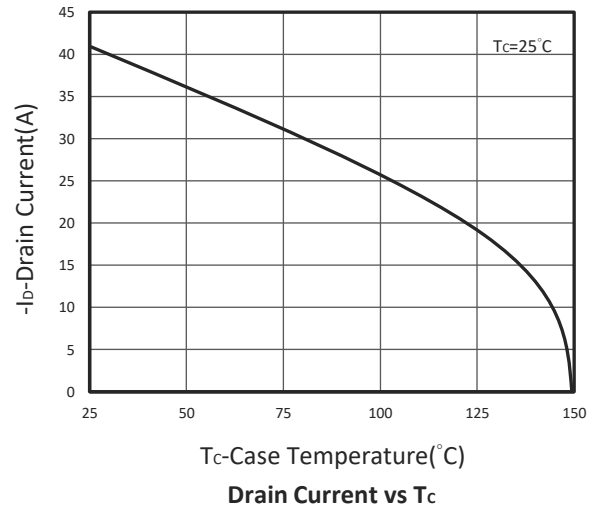
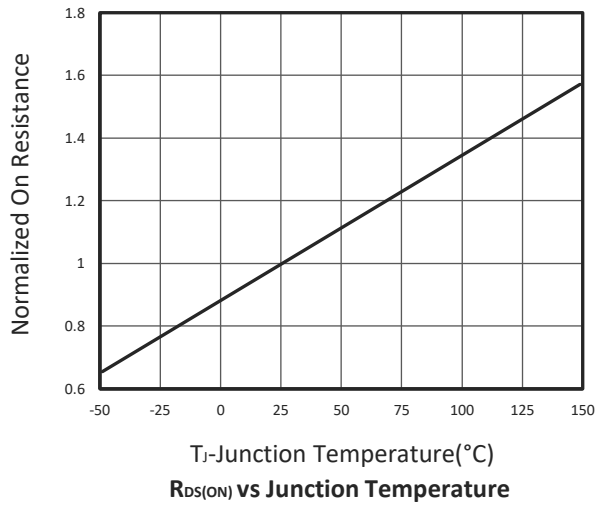
- A. Surface mounted on FR4 board using 1 in<sup>2</sup> pad size.
- B. Pulsed width limited by maximum junction temperature, T<sub>J(MAX)</sub>=150 $^\circ$ C (initial temperature T<sub>J</sub>=25 $^\circ$ C).
- C. Using  $\leq$  10s junction-to-ambient thermal resistance is base on T<sub>J(MAX)</sub>=150 $^\circ$ C.
- D. Pulse test width  $\leq$ 300 $\mu$ s and duty cycle  $\leq$  2%.
- E. Guaranteed by design, not subject to production testing.

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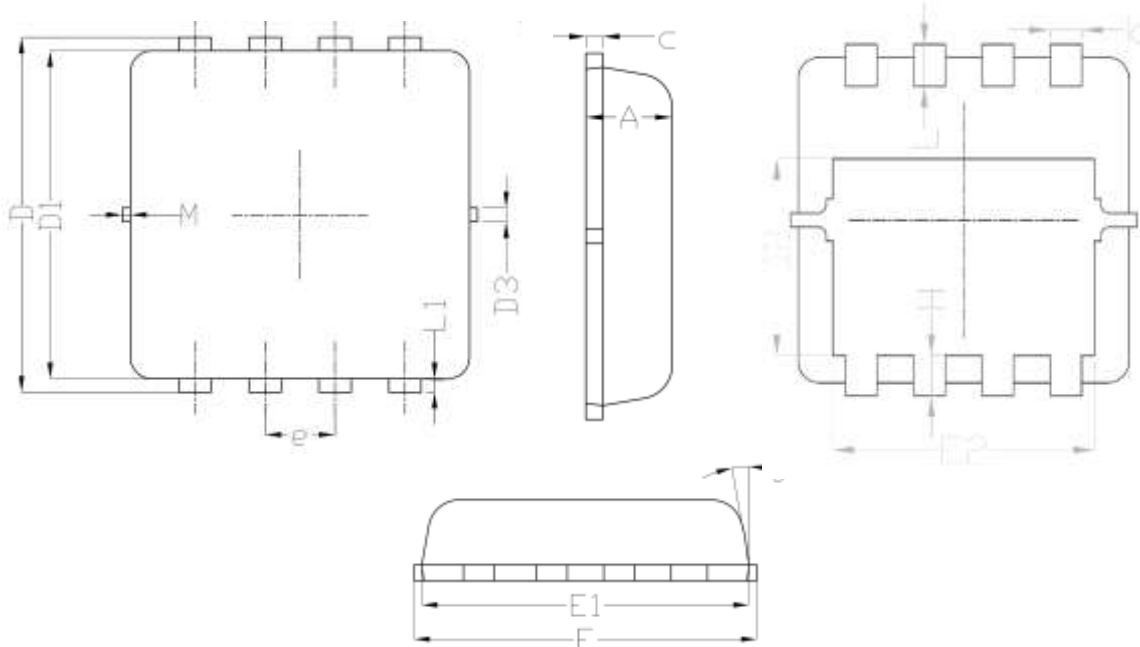
## TYPICAL CHARACTERISTICS



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## DFN3.3X3.3A-8 PACKAGE DIMENSIONS



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min.	Max.	Min.	Max.
A	0.700	0.800	0.028	0.031
b	0.250	0.350	0.010	0.014
c	0.100	0.250	0.004	0.010
D	3.250	3.450	0.128	0.136
D1	3.000	3.200	0.118	0.126
D2	1.780	1.980	0.070	0.078
D3	-	0.130	-	0.005
E	3.200	3.400	0.126	0.134
E1	3.000	3.200	0.118	0.126
E2	2.390	2.590	0.094	0.102
e	0.65BSC.		0.026BSC.	
H	0.300	0.500	0.012	0.020
L	0.300	0.500	0.012	0.020
L1	-	0.130	-	0.005
M	-	0.150	-	0.006
Θ	0°	12°	0°	12°

Recommended Land Pattern

